

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10590557	GAO ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
David Ton	2117	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
714	719	2/29/08	DT
714	746	2/29/08	DT
375	377	2/29/08	DT
714	701	2/29/08	DT
714	702	2/29/08	DT
714	755	2/29/08	DT

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST, JPO, DERWENT, IBM-TDB, IEEE searches	2/29/08	DT

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
714	702	2/29/08	DT
714	755	2/29/08	DT